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Published in:
Journal of Materials Chemistry A

DOI:
10.1039/c4ta04785k

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Document Version
Publisher's PDF, also known as Version of record

Publication date:
2015

Link to publication in University of Groningen/UMCG research database

Citation for published version (APA):

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Origin of the increased open circuit voltage in PbS–CdS core–shell quantum dot solar cells†


Lead sulfide quantum dots (PbS QDs) show great potential for efficient, low cost photovoltaic applications. Currently, device efficiencies are limited by the high density of trap states caused by lattice imperfections on the QD surface. Introducing a thin shell of a wide bandgap semiconductor to the QD surface is a promising method to passivate these trap states. Here we demonstrate solar cells made from PbS–CdS core–shell QDs, yielding a 147 mV increase in VOC compared to core only PbS QDs. We explore the physical reason for this enhancement and demonstrate that it is indeed caused by improved passivation of the PbS surface by the CdS shell, leading to a lower electron trap density.

Introduction

Semiconducting colloidal nanocrystals, also known as quantum dots (QDs), have emerged as a promising class of materials for third generation photovoltaic applications. QDs offer the prospect of highly efficient and long-term stable solar cells using low-cost, solution based processing techniques. Confinement of the charge carriers in QDs leads to discretization of the energy levels and widening of the bandgap, allowing the optical and electronic properties to be finely tuned by varying the QD size. In particular, PbS QDs have been used in the fabrication of devices with various structures such as QD sensitized solar cells, Schottky diodes, planar heterojunction, and bulk-heterojunction solar cells. Their success stems from the broad light harvesting capability spanning the UV, visible, and NIR regions of the spectrum up to approximately 2 μm and potentially beyond.

After synthesis, lead chalcogenide QDs are typically surrounded by long aliphatic ligands such as oleic acid (OA) or oleylamine. The ligands provide solubility in apolar solvents, prevent ripening or aggregation, and passivate the particle surface. These ligands, however, also act as a barrier to charge transfer and transport between neighboring QDs, and must therefore be removed for electronic device applications. Typically, this is done by exposing the QD film to one or several shorter ligands, such as aromatic thiols, short alkyl thiols, mercaptotropionic acid, and more recently, halide anions. When ligand exchange takes place, the inter-dot distance is decreased, and the electronic wave functions between adjacent QDs overlap. This allows charge carrier mobilities in the QD film to be enhanced by several orders of magnitude. Nevertheless, the ligand-exchange procedure also introduces many surface defects such as vacancies and dangling bonds. These defects favor trap-assisted recombination, which inhibits the splitting of the quasi-Fermi energy levels under illumination and consequently limits the maximum achievable open circuit voltage (VOC). For this reason, proper electronic passivation of ligand-treated QD surfaces is a crucial prerequisite for highly efficient solar cells. One method to passivate the QD surface focuses on repairing surface defects by exposure to various small molecular and atomic ligands. Another, less explored, method is to introduce a passivation layer already during the synthesis of the QD to prevent trap states rather than repairing them. The latter strategy can be achieved by introducing during synthesis a shell of a wide bandgap semiconductor such as CdS to the surface of PbS, to obtain PbS–CdS core–shell QDs.

Recently, we reported PbS–CdS core–shell QD sensitized solar cells on mesoporous TiO2 nanoparticles, using 3-mercaptotropionic acid ligand exchange. A substantial increase in VOC of 150 mV was observed when covering PbS QDs with a 0.5 nm thick shell of CdS. Further increasing the shell thickness provided only a marginal additional increase in VOC and was accompanied by a significant drop in JSC due to the added barrier for charge transport. It was also shown that the mean electron lifetime and diffusion length increase with increasing shell thickness, suggesting that the increase in VOC is due to suppressed non-radiative charge recombination. Other reports have also described PbS–CdS QDs in solar cells, most recently exhibiting a power conversion efficiency (PCE) of 5.6% with PEDOT and ZnO as hole and electron transporting layers.
PbS QDs are synthesized using a previously described hot-injection method. Core–shell QDs are then obtained by Cd\textsuperscript{2+} cation exchange in parent PbS QDs. After the shell is formed, a blue shift of the first excitonic peak from 1095 nm to 1069 nm is observed (Fig. S1†), which is attributed to the size reduction of the PbS core when Pb\textsuperscript{2+} atoms are replaced by Cd\textsuperscript{2+}. The size of the PbS QDs is determined to be 3.69 nm using an empirical formula developed by Moreels et al. relating the bandgap \( E_g \) and the diameter \( d \) of PbS QDs:\textsuperscript{24}

\[
E_g [\text{eV}] = 0.41 + \frac{1}{0.0252d^2 + 0.283d}.
\]  

(1)

From the blue shifted peak of the core–shell QDs, this equation indicates a reduced core diameter of 3.57 nm and, consequently, an approximated shell thickness of 0.065 nm. The actual shell thickness is likely higher, since this equation assumes perfectly spherical particles and does not take into account the shared sulfur atom between the Pb and Cd atoms. Furthermore, the shell allows partial relaxation of quantum confinement of the charge carrier wavefunctions into the shell compared to the ligand/solvent environment, leading to a partial reduction of the blue shift and an underestimation of the shell thickness. The overall diameter of the core–shell QDs observed in scanning TEM (STEM) micrographs is the same as the parent core diameter within measurement resolution.

Although the similar lattice parameters of PbS (rock salt, \( a = 0.59 \) nm) and CdS (zinc blende \( a = 0.58 \) nm) impede direct observation of the shell in the micrographs, the presence of the CdS shell is confirmed by energy-dispersive X-ray spectroscopy (EDXS) measurements performed on the QDs shown in Fig. S3.† Ligand exchange has been demonstrated to be a fundamental step towards increasing QD film conductivity.\textsuperscript{25} In this study, ligand exchange is achieved by exposing QD films to a solution of 1,4-benzenedithiol (BDT) in acetonitrile. The optical bandgap is examined both before and after ligand exchange. For the core only QDs the ligand exchange process results in a significant redshift of the excitonic peak from 1023 nm to 1048 nm in the absorbance spectrum (Fig. 1a). This is explained by partial loss of quantum confinement when the inter-dot distance is decreased. In contrast, the core–shell QDs undergo a much smaller redshift upon ligand exchange, indicating that quantum confinement is much more preserved, due to the additional barrier caused by the CdS shell. The distance between PbS QDs has previously been shown to be \( \sim 0.5 \) nm.\textsuperscript{14} The addition of a 0.1 nm shell to each QD effectively increases the distance between the cores by \( \sim 40\% \), which affects the

![Absorbance spectra of QDs capped with oleic acid (OA) in solution (solid line) and capped with 1.4-benzenedithiol (BDT) in film (dashed line) for (a) the PbS QDs and (b) PbS–CdS core–shell QDs. Inset: STEM image of the core–shell QDs capped with OA. The low contrast ring around the crystallic center is likely due to the organic capping ligands.](image-url)
degree of wave function overlap between adjacent QDs, and consequently the bandgap.

Recently, we have developed a method to determine the electronic bandgap of this class of materials using ionic liquid gated field effect transistors.\textsuperscript{22} For these materials, the electronic bandgap obtained with this method differs only 2–5% with the optical bandgap.\textsuperscript{26} In this study therefore, the position of the excitonic peak is used for facile determination of the optical and electronic bandgap. Both types of QDs used in this study exhibit excitonic peaks around 1050 nm in film, corresponding to a bandgap of 1.18 eV.

PbS and PbS–CdS Schottky solar cells with active layer thickness of ∼130 nm are fabricated in inert atmosphere using a previously reported layer-by-layer deposition procedure.\textsuperscript{2,6} The resulting current–voltage responses of these devices are shown in Fig. 2a, and the device parameters are summarized in Table 1. For the core only devices, a $V_{OC}$ of 0.44 V, a short circuit current ($J_{SC}$) of 10.8 mA cm$^{-2}$, a fill-factor (FF) of 43%, and a PCE of 2.1% are observed. It should be noted that while the $J_{SC}$ and FF in these devices are lower than in our previous reports, the $V_{OC}$ is comparable to that of the best Schottky devices reported for PbS QDs of similar bandgap.\textsuperscript{2} For the best core–shell device, a slightly smaller $J_{SC}$ of 10.0 mA cm$^{-2}$, a largely unchanged FF of 44%, and a significantly increased $V_{OC}$ of 0.59 V are observed, resulting in a PCE of 2.5%. This increase in $V_{OC}$ is comparable to what has been recently reported for core–shell QDs.\textsuperscript{18,29} A significantly reduced loss of $V_{OC}$ is observed compared to the built in voltage $V_{bi}$, defined as the voltage where the light and dark current are equal; the difference between the $V_{OC}$ and $V_{bi}$ for the core only device is 62 mV, while for the core–shell device the difference is only 2 mV. A histogram of the $V_{OC}$’s for all prepared devices is displayed in the inset of Fig. 1a, showing the high level of reproducibility of the $V_{OC}$ improvement.

In Fig. 2b, the external quantum efficiency (EQE) spectra are plotted for both devices. Convolution of the EQE and the solar spectrum gives a predicted $J_{SC}$ of 10.9 mA cm$^{-2}$ and 9.4 mA cm$^{-2}$ for the core only and core–shell solar cells, respectively, which is in good agreement with the values obtained from the $JV$-curves. The slight loss in $J_{SC}$ of the core–shell device can be traced to a lower EQE in the visible region of the solar spectrum. Since the reduction in EQE is limited to the visible, we attribute this loss either to a slightly lower absorption coefficient in the visible or to optical cavity effects arising from a changed permittivity of the QD solid (see below) rather than to decreased transport properties or increased recombination, which would reduce the EQE uniformly across the spectrum. It is important to note that the positions of the excitonic peaks in the EQE spectra match those of the absorbance spectra and are identical to note that the positions of the excitonic peaks in the EQE spectra.

To understand if there is any difference in the Fermi energy level between core only and core–shell QDs, impedance spectroscopy measurements of the Schottky devices are conducted in the dark under forward bias conditions. Devices as thin as ∼70–80 nm are fabricated to ensure that the depletion width extends throughout the active layer. The impedance spectra for both the core only and core–shell devices feature a single arc (Fig. S4†), which is fitted using the equivalent circuit displayed in the inset of Fig. 3 to obtain the capacitance per unit area ($C = C/A$, where $A$ is the device area defined by the electrode overlap). From the Mott–Schottky equation we have,

$$\frac{1}{C^2} = \left( \frac{2}{\varepsilon N\varepsilon_0} \right) \left( V - V_{bi} - \frac{kT}{e} \right),$$

where $N$ is the density of free charge carriers in the device, $\varepsilon$ is the material’s relative permittivity, and $\varepsilon_0$ is the permittivity of vacuum. Thus, plotting $C^2$ versus the applied bias allows the flat-band potential $V_{bi}$ to be extracted as a qualitative measure of the depth of the Fermi level in the bandgap. For the core only device we find $V_{bi} = 758$ mV, whilst for the core–shell we find a slightly lower value of 734 mV, indicating that the core–shell QDs are marginally less p-doped and the Fermi level lies closer
to the middle of the bandgap. Since the flat-band potential is an upper limit for the maximum obtainable open circuit voltage, the slightly lower value found in the core–shell QDs has a small detrimental effect on the value of the $V_{OC}$, and cannot explain the increased $V_{OC}$ found in the experiments. From fully depleted solar cell devices (Fig. S5†), the relative permittivity can also be calculated according to the parallel-plate capacitance $C = \varepsilon_0 \varepsilon A/d$, where $\varepsilon$ is the relative permittivity of the QD material and $d$ is the device thickness. Relative permittivities are calculated to be $\varepsilon \sim 21–24$ for core only and $\varepsilon \sim 15–17$ for core–shell QDs. Despite this significant difference in permittivity, the electronic bandgap calculated from the excitonic peak is not greatly influenced, since for both QDs, the excitonic binding energies are very small.27,28

Time resolved PL measurements can give important information on the dynamics of the photoexcitations in our QD films, and consequently on the formation of photoexcited carriers. From the transient measurements reported in Fig. 4, the lifetimes of excited states are extracted both for OA and BDT capped QDs. For the OA capped QD films, the dynamics are described by mono-exponential decay with lifetime $\tau = 42$ ns for the core only and a much increased lifetime of $\tau = 406$ ns for core–shell QDs. After ligand exchange with BDT, a reduction of the decay time of more than two orders of magnitude is observed for both types of QDs and the decay dynamics become bi-exponential with a fast component $\tau_1 = 0.33$ ns and a slower component $\tau_2 = 0.98$ ns for core only, and $\tau_1 = 0.33$ ns, $\tau_2 = 4.2$ ns for core–shell QDs. Interestingly, the increased lifetime of the core–shell QDs occurs despite a lower permittivity, which leads to reduced dielectric screening of the radiating field inside the QDs.29 Although this increase may be partially due to improved surface passivation, other factors must first be considered. It has been shown for example, that for PbSe–CdSe core–shell QDs with shell thickness of 1.6 nm the charge carrier lifetime is increased due to a reduced electron–hole overlap within a single QD, caused by the delocalization of the electron

<table>
<thead>
<tr>
<th>Sample</th>
<th>$J_{SC}$ [mA cm$^{-2}$]</th>
<th>$V_{OC}$ [V]</th>
<th>FF [%]</th>
<th>PCE [%]</th>
</tr>
</thead>
<tbody>
<tr>
<td>PbS</td>
<td>10.8 (9.3 ± 1.3)*</td>
<td>0.44 (0.44 ± 0.02)</td>
<td>43 (40 ± 2)</td>
<td>2.1 (1.7 ± 0.3)</td>
</tr>
<tr>
<td>PbS–CdS</td>
<td>10.0 (8.2 ± 1.5)</td>
<td>0.59 (0.52 ± 0.06)</td>
<td>44 (45 ± 4)</td>
<td>2.5 (2.0 ± 0.5)</td>
</tr>
</tbody>
</table>

* The average and standard deviation calculated over all samples are given in brackets.

Fig. 3 Inverse square of the capacitance per unit area ($C' = C/A$) extracted from impedance spectra in the dark (Fig. S4†). The data are fitted according to the equivalent circuit displayed in the inset. The intersection of the extrapolated linear regime with the $x$-axis is proportional to the flatband potential, more precisely ($V_{fb} + kT/e$).

Fig. 4 (a) Photoluminescence decay dynamics of oleic acid capped QD films, and the corresponding time constants extracted by mono-exponential decay fitting. (b) Photoluminescence decay dynamics for QD films after ligand exchange with 1,4-benzenedithiol, and the corresponding time constants extracted from bi-exponential decay fitting.
wave function into the shell while the hole is confined to the core.\textsuperscript{16} Since the QDs used in this study have an extremely thin shell, this effect is assumed to be negligible. The quantum confinement must also be considered as an important parameter affecting exciton lifetime, since in more confined systems the charge carriers have less probability for bimolecular recombination. We have seen from the absorbance spectra that the degree of quantum confinement does differ significantly, therefore it is difficult to separate the effect of reduced trap-assisted recombination from the effect of reduced bimolecular recombination. The effect of surface passivation is expected to be more evident in the BDT capped QDs, since many of the traps in PbS QDs are introduced during the ligand exchange process. The difference in lifetimes between the core only and core–shell QDs, however, is larger for the OA capped QDs, suggesting that quantum confinement is the dominant factor in these measurements, and not surface passivation.

The current density in an ideal Schottky solar cell can be described by the Shockley diode equation,

$$J = J_0 \left[ \exp \left( \frac{eV}{nkT} \right) - 1 \right] - J_{\text{ph}},$$

where $J_0$ is the reverse saturation current density, $J_{\text{ph}}$ is the photocurrent, $e$ is the elementary charge, $n$ is the ideality factor, $k$ is Boltzmann’s constant, $T$ is the temperature, and $V$ is the applied voltage across the solar cell. The ideality factor is determined by the dominant trapping mechanism in the solar cell, and is therefore an informative parameter to determine the degree of surface passivation in these devices. One method to obtain the ideality factor is by fitting the exponential regime of the dark current $J_0$ as a function of the applied bias. This method is complicated for the solar cells studied here due to the lack of a well-defined exponential regime at low forward bias (Fig. S6†). Therefore the ideality factor is in this case more accurately determined at open circuit conditions ($J = 0$), for which eqn (3) can be rearranged to

$$V_{\text{OC}} = \frac{nkT}{q} \ln \left( \frac{J_{\text{ph}}}{J_0} \right) = \frac{nkT}{q} \ln(I^*) + C,$$

where $I^*$ is the illumination intensity, $C$ is a term collecting the intensity independent terms, and $\gamma$ is an empirical parameter indicating the degree of linearity of $J_{\text{ph}}$, with the illumination intensity, found here to be 0.96 and 1.00 for the core only and core–shell QDs respectively, as shown in Fig. S7†. Hence by plotting the $V_{\text{OC}}$ against the illumination intensity $I^*$ on a semi-logarithmic plot, the ideality factor $n$ can be extracted from the slope of the curve. The ideality factor gives an indication of the dominant recombination mechanism in the device, with $n = 1$ corresponding to ideal bimolecular recombination, and $n = 2$ corresponding to fully trap-assisted recombination via mid-gap trap states.\textsuperscript{15,21} Two regimes are observed for both the core only and core–shell QDs (Fig. 5). At low light intensity, both devices are trap dominated, with $n = 2.04$ and $n = 1.93$ for the core only and core–shell, respectively. As the light intensity is increased, more traps are filled and the density of charge carriers increases, increasing the probability of bimolecular over trap-assisted recombination. For the core only QDs, this leads to a reduction of the ideality factor to $n = 1.46$, indicating that trap-assisted and bimolecular recombination both play a significant role at 1-Sun intensity. For the core–shell QDs at about 1-Sun intensity, we have $n = 1.08$, establishing that bimolecular recombination dominates. Therefore, this validates the idea that trap-assisted recombination is suppressed in core–shell QDs.

One of the consequences of a high density of trap states is the pinning of the Fermi level to the trap energy levels. Therefore, the ability to shift the Fermi level within the bandgap via an applied bias gives insight into the density of trap states. For this reason, SiO$_2$-gated FETs were fabricated, of which the output and transfer characteristics are shown in Fig. 6. Both the core only and core–shell transistors exhibit ambipolar transport behavior. The gating effect for the core–shell QDs is slightly larger for the p-channel (Fig. 6a, left panel) and significantly enhanced for the n-channel compared to core only QDs (Fig. 6a, right panel). From the transfer characteristics of the n-channel (Fig. 6b), a shift in the sub-threshold gate voltage and an increased sub-threshold swing (from 9.1 V dec$^{-1}$ to 6.3 V dec$^{-1}$) is observed for the core–shell FET. The improved gating effect and steeper sub-threshold swing in the n-channel indicate that the Fermi level can be moved more freely in the core–shell QDs, and is less pinned by trap states than in the core only QDs.\textsuperscript{22} For the p-channel transfer characteristics, no significant change is observed between the two types of QDs (Fig. S8†), suggesting that the CdS shell passivates mostly electron traps. Charge carrier mobility values are extracted from the linear current regime according to the gradual channel approximation and using a parallel plate capacitor model for the gate electrode charge accumulation. In this way, for the core only QDs, charge carrier mobilities of $\mu_h = 5.9 \times 10^{-8}$ cm$^2$ V$^{-1}$ s$^{-1}$ and $\mu_e = 5.5 \times 10^{-6}$ cm$^2$ V$^{-1}$ s$^{-1}$ are obtained for the hole and electron respectively. For the core–shell QDs, a similar value for the hole mobility is found $\mu_h = 5.5 \times 10^{-8}$ cm$^2$ V$^{-1}$ s$^{-1}$ and a marginally lower electron mobility $\mu_e = 4.1 \times 10^{-6}$ cm$^2$ V$^{-1}$ s$^{-1}$ for the core–shell QDs.
of the trap states. In contrast, core only QDs maintain the signature of trap-assisted recombination even at 1-Sun intensity.

FETs fabricated with core–shell QDs demonstrated increased shifting of the Fermi level under applied gate voltage for the n-channel, demonstrating a reduced electron trap density. The reduced trap density allows more efficient splitting of the quasi-Fermi levels in core–shell QDs and consequently a higher Voc, making this a highly promising material for QD solar cell applications.

**Experimental section**

**QD synthesis**

PbS QDs are synthesized using a previously described hot injection method, whereby a lead precursor solution consisting of 1.516 g PbAc2·H2O in 50 ml ODE and 4.5 ml OA is vacuum dried at 120 °C in a three-neck reaction flask. The temperature is subsequently raised to 145 °C after which a sulfur precursor of 0.420 ml TMS2S in 10 ml ODE is quickly injected and the flask cooled in a water bath. Hexane and ethanol are added to the solution, followed by centrifugation to separate the QDs. Two more washing steps are performed by re-dispersion in hexane and precipitation by ethanol and finally the QDs are re-dispersed in chloroform. PbS–CdS QDs are obtained by cation exchange in PbS QDs, described in detail elsewhere. In short, parent PbS QDs are injected into a three-neck flask containing a solution of CdO, 1-octadecene (ODE) and OA, and kept at 100 °C for a reaction time of 45 minutes. Ethanol is then used to precipitate the PbS–CdS core–shell particles, after which two re-dispersion/precipitation steps are performed with toluene and ethanol respectively. Finally, the PbS–CdS core–shell particles are re-dispersed in chloroform.

**STEM and EDXS characterization**

STEM micrographs are made using a FEI Tecnai F30 microscope, operating at 300 kV acceleration potential. EDXSA analysis is performed using a JEOL JSM-6400 scanning electron microscope. Samples are fabricated by dropcasting 1–2 μL of mild solution of QDs in toluene onto a carbon coated copper grid. No further washing treatment is performed.

**Solar cell fabrication**

In inert atmosphere, PbS or PbS–CdS QDs are spincoated from chloroform solution (10 mg ml⁻¹) on substrates pre-patterned with indium tin oxide (ITO). Ligand exchange is carried out by exposing the film to a 20 mM solution of 1,4-benzenedithiol (BDT) in acetonitrile for 30 seconds, followed by spin-drying without any additional washing steps. Complete removal of the OA ligand by this method has previously been confirmed by FTIR spectra. This process is repeated ~10 times, yielding smooth films of approximately 130 nm thick as determined by a Dektak Profilometer. The devices are then annealed at 140 °C for 5 minutes. Sintering or major modification of the QD surface from this step can be ruled by observing the unchanged excitonic peak from absorption measurements. Finally, the top contacts are deposited by thermal evaporation of 1 nm LiF and

**Conclusion**

We have demonstrated enhanced Schottky solar cells with PbS–CdS core–shell QDs. In comparison with core only PbS QDs, devices fabricated with core–shell QDs give rise to an increase in the Voc of up to 147 mV. We have excluded an altered bandgap as the origin of the improved Voc by adjusting the QD counterparts to exhibit identical bandgaps after film formation and ligand exchange, and demonstrated an almost identical flat-band potential for both types of QDs to exclude the effect of a shifted Fermi level.

From absorbance spectra, a much smaller redshift for core–shell QDs is observed after ligand exchange, indicating increased quantum confinement, leading to a longer excitation lifetime as revealed by time resolved PL spectroscopy.

The dominant recombination mechanism in core–shell QDs is determined to be trap-assisted recombination at low light intensity. At 1-Sun intensity, however, bimolecular recombination takes over for core–shell QDs, indicating an effective filling of the trap states. In contrast, core only QDs maintain the
100 nm Al at <10^{-6} mbar. Device areas are defined by the overlap of the Al and ITO electrodes to be 16 mm². In total, 19 devices were fabricated for each type of QD.

Transistor fabrication

Silicon substrates covered by a 230 nm thick SiO₂ layer and pre-patterned gold electrodes with 5 μm channel length and 10 mm channel width are used for transistor fabrication, upon which a ~50 nm film of QDs is deposited using the same layer-by-layer method and annealing step used for solar cell devices. The measurements are performed in inert atmosphere using an Agilent E5262A Semiconductor Parameter Analyzer.

J-V characterization

Current-voltage sweeps are carried out in inert atmosphere under simulated AM1.5 G solar illumination using a Steuernagel Solarconstant 1200 metal halide lamp set to 100 mW cm⁻² intensity, as measured by a silicon reference cell, and corrected for the spectral mismatch. Under illumination, a shadow mask with slightly smaller area (9 mm²) is used to exclude lateral contributions to the photocurrent from beyond the device area.

EQE measurements

External quantum efficiencies are measured under monochromatic light conditions at short circuit conditions, using the same shadow masks as in the J-V characterization measurements. As a light source, a 250 W quartz tungsten halogen lamp (6334NS, Newport) with lamp housing (67009, Newport) is used. Monochromatic light is achieved using narrow band pass filters (Thorlabs) with a full width half maximum (FWHM) of 10 ± 2 nm from 400 nm to 1250 nm and a FWHM of 12 ± 2.4 nm from 1300 nm to 1400 nm. Light intensity is determined by calibrated PD300 and PD300IR photodiodes (Ophir Optics).

PL measurements

PbS and PbS–CdS QDs films are deposited on quartz substrates by dropcasting (OA capped) or by using the aforementioned layer-by-layer technique (BDT capped). The samples are then annealed at 140 °C for 3 minutes. The samples were excited at 400 nm by the second harmonic of a modelocked Ti : sapphire (Mira 900) laser delivering pulses of 150 fs. An optical pulse selector is used to vary the repetition rate of the exciting pulse. Time-resolved traces are recorded with a Hamamatsu streak camera working in synchroscan mode and single sweep mode for different lifetime measurements. All measurements are performed in an optical cryostat. Samples are loaded inside a glove box to maintain an oxygen-free environment at all times.

Impedance spectroscopy

Impedance spectroscopy measurements were conducted under dark conditions. A forward bias ranging from 0–0.8 V is superimposed with a 15 mV ac signal over the frequency range 1 MHz–50 mHz. The data are fitted using the equivalent circuit displayed in the inset of Fig. 3 to extract the capacitance.

Acknowledgements

M. J. Speirs and M. A. Loi acknowledge the financial support of the Alumnikring Den Haag/Rotterdam through the Ubbo Emmius Fund of the University of Groningen. M.A.L acknowledges also the support of the ERC Starting Grant “Hybrids Solution Processable Optoelectronic Devices” (Hy-SPOD) (ERC-306983); M.K. acknowledges partial financial support from ERC Starting Grant NANOSOLID (GA no. 306733). M.J.S. would like to thank S. Z. Bisri for fruitful discussions.

Notes and references

26 S. Bisri, personal communication, 10 September, 2014.

27 We can estimate the binding energy of both materials using $E_b = -\varepsilon^2 m_e m_h (m_e + m_h)^{-1} R_y$, where $\varepsilon$ is the relative permittivity, $m_e$ and $m_h$ are the effective electron and hole mass, $m$ is the free electron mass, respectively, and $R_y$ is Rydberg’s constant. Assuming the effective mass of charge carriers in the core is not affected by the thin shell, we can use $m_e = m_h = 0.09 m_e^{*a}$ to obtain $E_b = 1.2$ meV for PbS QDs and $E_b = 2.1$ meV for PbS–CdS QDs. This is negligible compared to the optical bandgap.


